

## **Enhanced Light Transmission Conductive Coated Transparent Substrate and Method for Making Same**

### **Cross Reference to Related Application**

This application claims priority from United States Provisional Patent Application Serial  
5 No. 60/213,663, filed on June 23, 2000, the disclosure of which is hereby incorporated herein by  
reference in its entirety.

### **Background of the Invention**

This invention relates to an improved conductive coated transparent substrate as used in a  
touch screen, or a digitizer panel, or a substrate in an information display such as a liquid crystal  
10 display, a plasma display, a field emission display, an electroluminescent display, an  
electrochromic display, or a cathode ray tube display.

In the production of conductively coated transparent substrates for use in touch screens,  
digitizer panels or information displays such as those described above, it is desired that the  
screen, panel or display not only have a conductive coating providing electrical conductivity to  
15 allow activation of circuits, switches or other electrical devices controlled by the screen or panel,  
but also allow the maximum transmission of light so that the user of the screen, panel or display  
can easily read the information transmitted through the screen thereby allowing manual  
activation using the conductive coating layer. Typically, such screens, panels or displays make  
use of anti-reflective, thin film coatings or stacks to reduce or minimize glare while allowing  
20 optimal light transmission. However, the provision of a conductive coating layer on one side of  
a substrate including anti-reflective thin film stacks or coatings changes the optical  
characteristics of the coated substrate and can prevent maximized light transmission unless the  
anti-reflective thin films or stacks and conductive layer are properly designed, coordinated and  
prepared for one another.

In the past, anti-reflective, thin film coating stacks or multiple layers have been prepared  
25 either by vacuum deposition or wet deposition processes. Vacuum deposition is typically carried  
out through sputtering processes in which layers of thin films of materials such as metal oxides  
and metal halides are applied to a surface of a transparent glass or other substrate followed by a

second, third, fourth or other layers which together minimize or eliminate glare due to interference. However, in order to prepare one side of such a substrate for receipt of a conductive coating layer, it is necessary that vacuum sputtering deposition of the layers on either side of such a transparent substrate be prepared differently causing greater manufacturing time and expense.

Alternately, thin film coatings making up anti-reflective stacks or multilayers can be applied by wet deposition processes including dip coating in which the substrate is dipped in a container of liquid solution while held in a position perpendicular to the solution surface. When cured such as by firing, such process results in substantially identical coatings of the same solution on either side of the substrate. Although angle dipping or dipping of a substrate in a solution when held at an angle to the solution surface is known [such as is described in "Investigations on the Angle-Dependent Dip Coating Technique (ADDC) for the Production of Optical Filters", N.J. Arfsten et al., Journal of Sol-Gel Science and Technology 8, 1099-1104 (1997) © Kluwer Academic Publishers, the entire disclosure of which is hereby incorporated by reference herein], such angle dipping has heretofore not been used to prepare an improved conductive coated transparent substrate as in the present invention.

Accordingly, it was desired to provide a more efficient, less expensive, reduced glare, conductive coated panel having optimal light transmission, as well as a method for applying anti-reflective thin films or stacks to a transparent substrate using wet deposition processes such as dip coating while allowing preparation of the layers differently on each side of the substrate so that one or both sides are prepared for receipt of an electrically conductive coating to provide optimal light transmission characteristics through the coated substrate for use in touch screens, digitizer panels, information displays and the like.

### Summary of the Invention

This present invention contemplates use of angle dipping to establish one or more layers such as a multilayer stack of the same material type of thin films on the two opposite (first and second) surfaces of a substrate, and with the film thickness of an individual thin film on the second surface being different (such as for example, thicker) than its corresponding thin film (of the same material composition) on the first surface. The angle of dipping of the substrate when establishing the various layers of the multilayer stack on the respective surfaces is adjusted so that, when an additional outermost transparent conductor layer (or any other additional layer or

layers) is disposed on, for example, the outermost layer of the multilayer stack having the thinner individual layer thicknesses (compared to those on the opposing surface), visible light transmission through the coated panel is increased compared to the light transmission through that substrate coated only with the electrically conductive, transparent conductor layer.

5 In one aspect, the invention is a reduced glare, conductive coated panel comprising a transparent substrate having a first surface and a second surface, a first, multilayer, antiglare, interference stack disposed on the first surface of the substrate, the first stack comprising a plurality of transparent, thin film layers, and a second multilayer, antiglare, interference stack disposed on the second surface of the substrate, the second stack also comprising a plurality of  
10 transparent, thin film layers. The first of the layers in the first stack is positioned on the first surface and corresponds to the first of the layers in the second stack which is positioned on the second surface. The second of the layers in the first stack is positioned on the first layer and corresponds to the second of the layers in the second stack which is positioned on the first layer of the second stack. At least one of the layers of the first stack has a thickness greater than the  
15 thickness of the corresponding layer of the second stack on the second surface. Also included is a transparent conductive coating on at least one of the thin film layer of the first stack which is spaced farthest away from the first surface and the thin film layer of the second stack which is spaced farthest away from the second surface. Visible light transmission through the coated panel is increased as compared to the substrate coated only with the transparent conductive  
20 coating.

In preferred aspects of the invention, the transparent substrate may be glass or plastic, and the transparent conductive coating is applied to the second stack which has the thinner individual layers. Alternately, the transparent conductive coating may be applied to the first stack having the thicker individual layers. As yet another option, an electrically conductive coating may be  
25 applied to each of the first and second thin film stacks such that an electrically conductive coating is on each side of the coated substrate. Should the substrate have only a single, anti-glare, interference thin film on each of the opposite substrate sides, an electrically conductive coating may be applied over the single thin film layer on one or both of the opposite sides.

Additionally, each of the first and second thin film stacks may include a third transparent  
30 thin film layer positioned, respectively, on the second layer of each stack. Each of the layers of the first and second stacks has a refractive index with the refractive index of the second layer of

each of the first and second stacks preferably being greater than the reflective index of the other layers in the respective first and second stacks. Further, the refractive index of the third layer of each of the first and second stacks is preferably less than the refractive index of the other layers in those stacks.

In other aspects, the material composition of the corresponding layers in each of the first and second stacks or on opposite sides of the substrate may be the same. For example, the first layers in each of the first and second stacks maybe formed from a combination of silicon dioxide and titanium dioxide with each of the first layers having a refractive index at the sodium D line in the range of from about 1.5 to about 2.0. In addition, the second layers of each stack may be formed from titanium dioxide and have a refractive index at the sodium D line of at least about 2.0. Additionally, the third layers of each of the first and second stacks may be formed from silicon dioxide and have a refractive index at the sodium D line of less than about 1.5.

In yet another aspect, where each of the layers of the first and second stacks has a refractive index, the refractive index of the second layer of each of these first and second stacks is greater than the refractive index of the other layers in the respective stacks.

In yet another aspect, the invention is a method for making a reduced glare, conductive coated panel comprising providing a transparent substrate having a first surface and a second surface, and forming a first transparent thin film layer on the first surface and a first transparent thin film layer on the second surface by dipping the substrate in a liquid solution of a precursor of a material for the first transparent thin film layers while maintaining the substrate at an angle to the vertical whereby the first layer on the first surface has a thickness greater than the thickness of the first layer on the second surface, and applying a layer of transparent electrically conductive coating over at least one of the first layer on the first surface and the first layer on the second surface.

In preferred aspects of the method, the substrate may be fired at an elevated temperature to complete transformation of the as dipped layers into the transparent thin films prior to applying the next transparent thin film layer, or the layer of transparent electrically conductive coating.

Preferably, the angle at which the substrate is dipped in the liquid solution of precursor material is between about 5° and 25° to the vertical.

In other aspects, successive layers may be added to the layers on each side of the substrate by dipping the substrate in a liquid solution of a desired precursor material for those additional thin film layers while maintaining the substrate coated with the first layers at an angle to the vertical. Preferably, such additional layers are formed prior to application of the transparent electrically conductive coating on the last of the transparent thin film layers on the first or the second surface or both surfaces. Also, the angle at which the substrate is maintained while dipping to add such additional layers is preferably between about 5° and 25° to the vertical.

Accordingly, the present invention provides a reduced glare, conductively coated panel and a method for manufacturing same which allows preparation of each of the two sides of a substrate differently through the use of a lesser expensive, more highly efficient wet deposition process so that one side of the substrate is prepared to receive an additional electrically conductive coating layer so as to maximize light transmission through the coated substrate when such conductive coating is included.

### **Brief Description of the Drawings**

FIG. 1 is a schematic side elevation of a reduced glare, conductive coated panel in accordance with the present invention;

FIG. 2 is a schematic illustration of the preferred method of the present invention including dipping a substrate in a precursor solution at a predetermined angle for applying thin film layers to opposing sides of the substrate wherein the thin film layers have different thickness characteristics;

FIG. 3 is a schematic side elevation of a second embodiment of the reduced glare, conductive coated panel of the present invention; and

FIG. 4 is a schematic side elevation of a third embodiment of the reduced glare, conductive coated panel of the present invention.

### **Description of the Preferred Embodiments**

More specifically, and as shown in Figure 1, the invention relates to an improved reduced-glare conductive coated panel 40 comprising a substrate 10 such as glass having a first surface 12 and a second surface 14. Optionally, the transparent substrate of the present invention may be an optical plastic comprising a conductively coated cyclic olefin copolymer plastic substrate as disclosed in United States provisional patent application Serial No. 60/231,096, filed September 8, 2000, entitled PLASTIC SUBSTRATE FOR INFORMATION DEVICES, the

disclosure of which is hereby incorporated by reference herein in its entirety. Such rigid plastic substrate may be formed from a cyclic olefin copolymer (COC) such as is available from Ticona of Summit, New Jersey, under the trade name "Topas." Cyclic olefin-containing resins provide an improved material for a rigid, transparent conductively coated substrate suitable for use in an information display. The improved information display incorporating the improved plastic substrate is lightweight, durable, flex resistant, dimensionally stable and break resistant as compared to other, more conventional substrates. A rigid plastic substrate can be formed by extrusion, casting or injection molding. When injection molding is used such as when forming a substrate from a cyclic olefin copolymer (COC), a non-planar curved (spherical or multiradius) part can be formed, optionally with at least one surface roughened (such as by roughening/patterning a surface of the tool cavity used for injection molding) so as to have a light-diffusing, anti-glare property.

A transparent, plastic substrate such as one formed from cyclic olefin polymer resin can be used to form a rigid panel or back plate for use in a resistive membrane touch device where the cyclic olefin panel functions as a transparent back plate for a flexible, conductive, transparent touch member assembly as described in United States provisional patent application Serial No. 60/244,557, filed October 31, 2000, entitled PLASTIC SUBSTRATE FOR INFORMATION DEVICES, the disclosure of which is hereby incorporated by reference herein in its entirety.

In some applications, it may be useful to incorporate a flexible, transparent, conductively coated layer with a rigid, transparent, conductively coated substrate such as those described above to form an interactive information device such as a computer touch panel, a personal digital assistant known as a PDA, or a computer pen input device all as disclosed in United States provisional patent application Serial No. 60/234,867, filed September 22, 2000, entitled SPACER ELEMENTS FOR INTERACTIVE INFORMATION DEVICES, the disclosure of which is hereby incorporated by reference herein in its entirety. Such an assembly includes an improved process and materials for producing uniformly dispersed, consistent, durable, essentially non-visible, fixed substrate-interpane-spacer elements (for example "spacer dots") for spacing opposing conductive surfaces of the flexible top sheet and rigid bottom sheet or substrate of such an interactive information device.

With reference to Fig. 1, a multilayer antiglare interference stack 20 of interference thin films (for example a four layer multilayer stack ABCD with the individual thin films disposed

relative to the first surface 12 of substrate 10) is deposited on the first surface 12 of substrate 10 which may be any of those described above. The outermost thin film D in multilayer stack 20 comprises an electrically conductive, transparent conductor (such as indium tin oxide or doped tin oxide such as Sb or F doped tin oxide or doped zinc oxide) rendering stack 20 electrically  
5 conductive. Conductive thin film D is preferably applied by vacuum deposition, and more preferably by sputtering, to the outermost surface of stack 20 regardless of whether one, two, three or more layers of individual thin films such as A, B and C are included in the stack. Layers A, B and C comprise, respectively, a medium refractive index (RI) transparent thin film A (such as a mixed silicon dioxide/titanium dioxide layer and having a refractive index at the Sodium D  
10 line of in the range of from about 1.5 to about 2.0 RI); a high refractive index transparent thin film B (such as titanium dioxide and having a refractive index at the Sodium D line of at least about 2.0 RI); and a low refractive index transparent thin film C (such as silicon dioxide and having a refractive index at the Sodium D line of less than about 1.5 RI). The refractive index (RI) of layer B is greater than the RI of either layer A or layer C, and the RI of layer C is smaller  
15 than the RI of either layer A or layer B.

A multilayer antiglare interference stack 30 of thin films (for example a three layer multilayer stack A'B'C' with the individual thin films disposed relative to the second surface 14 of substrate 10 as shown in Figure 1) is deposited on the second surface 14 of substrate 10. In this embodiment, the outermost thin film D of multilayer stack 20 is absent from multilayer stack  
20 30. Layers A', B' and C' comprise, respectively, the same layer materials in multilayer stack 30 as layers A, B and C in stack 20. Thus, the material composition of thin film layer A' is the same as that of medium refractive index transparent thin film A. The material composition of thin film layer B' is the same as that of high refractive index transparent thin film B. The material composition of thin film layer C' is the same as that of low refractive index transparent  
25 thin film C. The refractive index (RI) of layer B' is greater than the RI of either layer A' or layer C', and the RI of layer C' is smaller than the RI of either layer A' or layer B'.

Optionally and alternately as shown in Fig. 3, instead of applying conductive thin film D to stack 20, a thin film D' comprising an electrically conductive, transparent conductor such as indium tin oxide or doped tin oxide as described above may be applied to the outermost surface  
30 of stack 30 on panel 40' to render stack 30 electrically conductive. In such case, the electrically conductive film D is absent from stack 20. Thin film D' may be applied over the outermost

surface of stack 30 regardless of whether one, two, three or more layers of individual thin films are included in the stack. Typically, thin film D or D' will be applied only to one stack 20 or 30 on only one side of substrate 10. However, in certain applications, a transparent electrically conductive coating D or D' can be applied to both stack 20 and 30 on panel 40" if desired as shown in Fig. 4 while achieving the desired optimized light transmission for this invention.

Importantly, in the preferred embodiment such as Fig. 1, the physical thickness (and hence the optical thickness) of each of layers A', B' and C' of multilayer stack 30 is different (such as thicker) than the corresponding respective physical thickness of each of layers A, B and C of multilayer stack 20. Optionally, the difference in physical thickness of layer A to layer A' can be about the same in dimension as measured in nanometers as is the difference in physical thickness of layer B to layer B' and can also be about the same in dimension as measured in nanometers as is the difference in physical thickness of layer C to layer C'. This preferably is achieved by utilizing generally the same angle of dipping for each of layer pairs A, A'; B, B'; and C, C'. Alternately, the difference in physical thickness, for example, between layer A and layer A' can itself be different than the difference in physical thickness between layer B and layer B' (or compared to the difference in physical thickness of any one layer to the other corresponding layer of that layer pair). Thus, the angle of dipping can be selected to achieve a desired difference in physical thickness within a layer pair and can also be chosen as different angle to establish a different condition for another layer pair. Also, as known in the sol-gel art, the physical thickness achieved on one surface of a substrate compared to that achieved on the opposing other surface is influenced by and a function of the withdrawal angle from the dip medium, the viscosity of the dip medium, the solids content of the dip medium, the temperature at which withdrawal from the dip medium occurs, and the speed of withdrawal of the substrate from the dip medium (i.e., the withdrawal rate of the substrate from the dip medium in inches of substrate height dimension per minute). Alternately, the orientation and angle of dipping can be adjusted and chosen so that the thickness of layers A, B, C and A', B', C' alternates between thicker and thinner on the same sides of the substrate, if desired.

As shown in Fig. 1, multilayer stack 20 reduces glare from light incident thereon for direction X and multilayer stack 30 reduces glare from light incident thereon for direction Y. Multilayer stacks 20 and 30 increase visible light transmission through panel 40 (which typically comprises a transparent glass substrate 10) by about 4%T as compared to substrate 10 coated



only with transparent electrically conductive layer D; and preferably by at least about 6%T; and most preferably by at least about 8%T. Transmission is measured across the visible light spectrum using a photopic detector.

Light transmission through improved reduced glare, conductive coated panel 40 is at least about 85%T; more preferably at least about 90% T; and most preferably by at least about 95% T.

Preferably, at least layers A,B, C, A',B' and C' are deposited by wet chemical deposition such as disclosed in commonly-assigned, United States Patent Nos. 5,900,275 to Cronin et al., 5,277,986 to Cronin et al., and/or 5,252,354 to Cronin et al., the disclosures of which are hereby incorporated by reference herein.

Most preferably, A, B, C, A', B' and C' are deposited by an angle dipping technique whereby panel 10 is dipped at an angle H (typically in the range of about 5 degrees to about 25 degrees to vertical or about 85 degrees to about 65 degrees to the horizontal) into a solution of a precursor of the material of thin films A, A'. Films A, A' are preferably then cured with ultra-violet (UV) light and/or air dried and/or heated/fired. After establishing thin films A and A' (or their precursors) on surfaces 12 and 14 of panel 10, panel 10 is next dipped at an angle G that may be the same or different from angle H and that is typically in the range of about 5 degrees to about 25 degrees to vertical or about 85 degrees to about 65 degrees to the horizontal into a solution of a precursor of the material of thin films B, B'. Films B, B' are preferably then cured with UV light and/or air dried and/or heated/fired. After thus establishing thin films A & B and A' and B' (or their precursors) on surfaces 12 and 14 of panel 10, panel 10 is further dipped at an angle I that may be the same or different from the previous dipping angles H and/or G and that is typically in the range of about 5 degrees to about 25 degrees to vertical or about 85 degrees to about 65 degrees to the horizontal into a solution of a precursor of the material of thin films C,C' to complete establishment of thin films A, B & C and A', B' and C' (or their precursors) on surfaces 12 and 14 of panel 10. Films C, C' are preferably then cured with UV light and/or air dried and/or heated/fired. After this, and after any elevated temperature firing in an oven to assure substantial completion of transformation of the as-dipped precursors of thin films A, B & C and A', B' and C' to their final desired composition and properties, conductive coating D is deposited preferably by vacuum deposition and most preferably by sputtering on layer C to complete formation of multilayer stack 20. As noted above, coating D' may optionally

be applied to stack 30, or coatings D or D' may be applied, one respectively to each of stacks 20 and 30, after formation of thin films A, B, C, A', B', or C'.

Alternately, thin films A, A', B, B' and C, C' can be respectively fired at an elevated temperature in an oven to substantially complete transformation of the as-dipped precursors of these films to their final composition and properties prior to dip application of the next layer set. Thus, thin films, A, A' can be dip-coated and fired prior to dip coating and firing of B, B', prior to dip coating and firing of C, C'.

Preferably, each of thin film layers A, B, C, A', B' and C' has a physical thickness after formation within the range of between about 0.01 and 10 microns. The specific thicknesses are selected as described above. Also, each of electrically conductive coatings D, D' may preferably have a thickness of between about 0.05 and 5 microns.

Figure 2 shows an angle dipping method useful in the present invention. A container 60 containing a liquid dip solution 50 is provided. Substrate 70 is inserted into dip solution 50 and is withdrawn from it in the direction XX and at an angle of  $\alpha$  degrees to the meniscus 55 of dip solution 50. Angle  $\alpha$  can be set at angle H, G, or I as set forth above. The opposing surfaces 92,94 of substrate 70 are coated with as-dipped films 85,80, respectively, of dip solution 50. When as-dipped films 85,80 are dried/cured (such as by heating in an oven, for example, at at least 100 degrees Celsius as is conventional), the physical thickness of then cured film 85 is different than that of fired film 80, and this difference in physical thickness is dependent on the angle  $\alpha$  used when withdrawing substrate 70 from dip solution container 60. Preferably, in this example, cured film 85 is thinner than cured film 80, and so on for the subsequent, other thin film layers.

While several forms of the invention have been shown and described, other forms will now be apparent to those skilled in the art. Therefore, it will be understood that the embodiments shown in the drawings and described above are merely for illustrative purposes, and are not intended to limit the scope of the invention which is defined by the claims which follow.